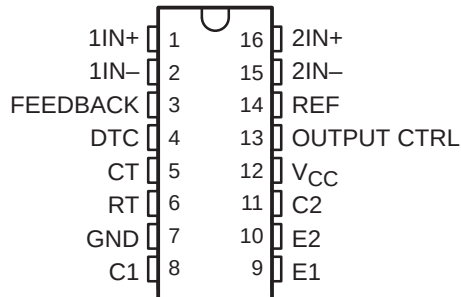


- Complete PWM Power Control Circuitry
- Uncommitted Outputs for 200-mA Sink or Source Current
- Output Control Selects Single-Ended or Push-Pull Operation
- Internal Circuitry Prohibits Double Pulse at Either Output
- Variable Dead Time Provides Control Over Total Range
- Internal Regulator Provides a Stable 5-V Reference Supply With 5% Tolerance
- Circuit Architecture Allows Easy Synchronization

D, N, NS, OR PW PACKAGE  
(TOP VIEW)



## description

The TL494 incorporates all the functions required in the construction of a pulse-width-modulation (PWM) control circuit on a single chip. Designed primarily for power-supply control, this device offers the flexibility to tailor the power-supply control circuitry to a specific application.

The TL494 contains two error amplifiers, an on-chip adjustable oscillator, a dead-time control (DTC) comparator, a pulse-steering control flip-flop, a 5-V, 5%-precision regulator, and output-control circuits.

The error amplifiers exhibit a common-mode voltage range from  $-0.3\text{ V}$  to  $V_{CC} - 2\text{ V}$ . The dead-time control comparator has a fixed offset that provides approximately 5% dead time. The on-chip oscillator can be bypassed by terminating RT to the reference output and providing a sawtooth input to CT, or it can drive the common circuits in synchronous multiple-rail power supplies.

The uncommitted output transistors provide either common-emitter or emitter-follower output capability. The TL494 provides for push-pull or single-ended output operation, which can be selected through the output-control function. The architecture of this device prohibits the possibility of either output being pulsed twice during push-pull operation.

The TL494C is characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ . The TL494I is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

FUNCTION TABLE

| INPUT TO<br>OUTPUT CTRL | OUTPUT FUNCTION                 |
|-------------------------|---------------------------------|
| $V_I = \text{GND}$      | Single-ended or parallel output |
| $V_I = V_{\text{ref}}$  | Normal push-pull operation      |



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS  
INSTRUMENTS**

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# TL494

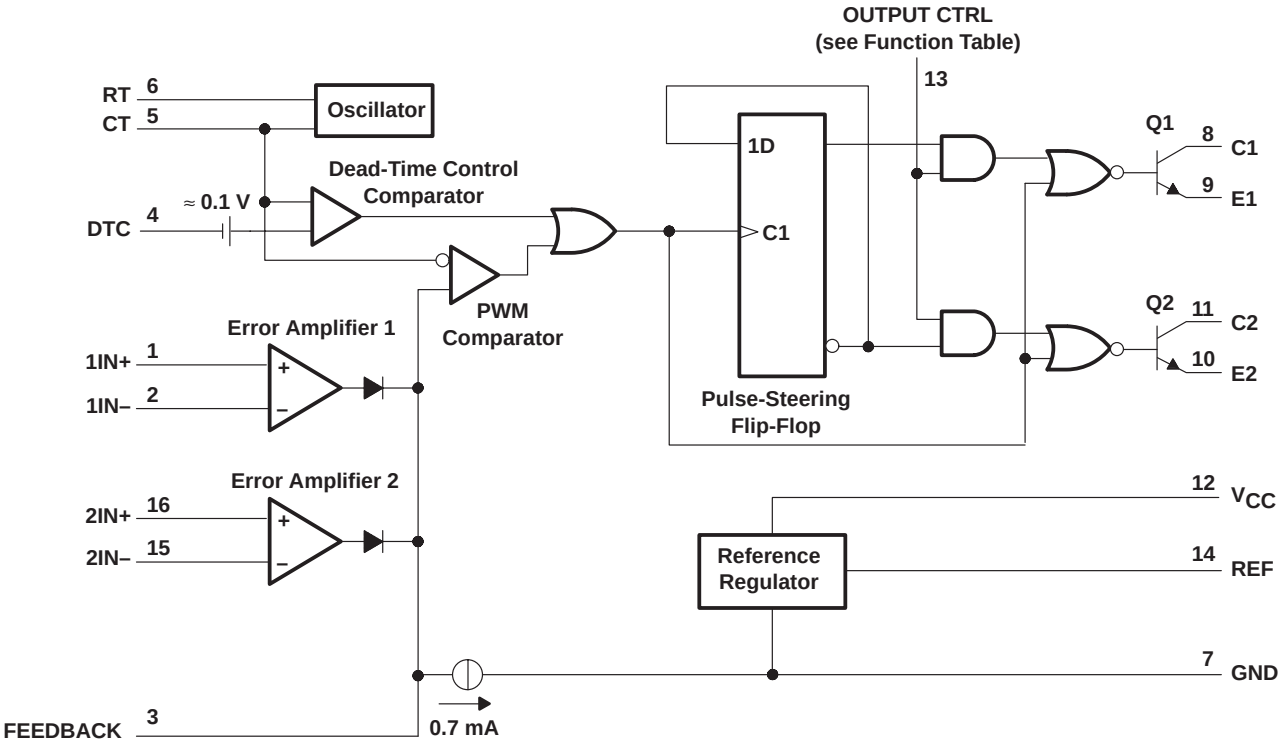
## PULSE-WIDTH-MODULATION CONTROL CIRCUITS

SLVS074B – JANUARY 1983 – REVISED JULY 1999

| AVAILABLE OPTIONS |                   |                 |                    |                           |               |
|-------------------|-------------------|-----------------|--------------------|---------------------------|---------------|
| T <sub>A</sub>    | PACKAGED DEVICES  |                 |                    |                           | CHIP FORM (Y) |
|                   | SMALL OUTLINE (D) | PLASTIC DIP (N) | SMALL OUTLINE (NS) | SHRINK SMALL OUTLINE (PW) |               |
| 0°C to 70°C       | TL494CD           | TL494CN         | TL494CNS           | TL494CPW                  | TL494Y        |
| –40°C to 85°C     | TL494ID           | TL494IN         | —                  | —                         | —             |

The D, NS, and PW packages are available taped and reeled. Add the suffix R to device type (e.g., TL494CDR). Chip forms are tested at 25°C.

### functional block diagram



# TL494 PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

|                                                                |                     | TL494                | UNIT |
|----------------------------------------------------------------|---------------------|----------------------|------|
| Supply voltage, V <sub>CC</sub> (see Note 1)                   |                     | 41                   | V    |
| Amplifier input voltage, V <sub>I</sub>                        |                     | V <sub>CC</sub> +0.3 | V    |
| Collector output voltage, V <sub>O</sub>                       |                     | 41                   | V    |
| Collector output current, I <sub>O</sub>                       |                     | 250                  | mA   |
| Package thermal impedance, θ <sub>JA</sub> (see Notes 2 and 3) | D package           | 73                   | °C   |
|                                                                | N package           | 88                   |      |
|                                                                | NS package          | 64                   |      |
|                                                                | PW package          | 108                  |      |
| Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds   | D, N, or PW package | 260                  | °C   |
| Storage temperature range, T <sub>stg</sub>                    |                     | −65 to 150           | °C   |

<sup>†</sup> Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES:
1. All voltage values, except differential voltages, are with respect to the network ground terminal.
  2. Maximum power dissipation is a function of  $T_J(\text{max})$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_J(\text{max}) - T_A)/\theta_{JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can impact reliability.
  3. The package thermal impedance is calculated in accordance with JEDEC 51, except for through-hole packages, which use a trace length of zero.

## recommended operating conditions

|                                            |        | TL494 |            | UNIT |
|--------------------------------------------|--------|-------|------------|------|
|                                            |        | MIN   | MAX        |      |
| Supply voltage, $V_{CC}$                   |        | 7     | 40         | V    |
| Amplifier input voltage, $V_I$             |        | –0.3  | $V_{CC}-2$ | V    |
| Collector output voltage, $V_O$            |        |       | 40         | V    |
| Collector output current (each transistor) |        |       | 200        | mA   |
| Current into feedback terminal             |        |       | 0.3        | mA   |
| Oscillator frequency, $f_{osc}$            |        | 1     | 300        | kHz  |
| Timing capacitor, $C_T$                    |        | 0.47  | 10000      | nF   |
| Timing resistor, $R_T$                     |        | 1.8   | 500        | kΩ   |
| Operating free-air temperature, $T_A$      | TL494C | 0     | 70         | °C   |
|                                            | TL494I | –40   | 85         |      |

# TL494

## PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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**electrical characteristics over recommended operating free-air temperature range,  $V_{CC} = 15\text{ V}$ ,  $f = 10\text{ kHz}$  (unless otherwise noted)**

### reference section

| PARAMETER                              | TEST CONDITIONS†                     | TL494C, TL494I |      |      | UNIT |
|----------------------------------------|--------------------------------------|----------------|------|------|------|
|                                        |                                      | MIN            | TYP‡ | MAX  |      |
| Output voltage (REF)                   | $I_O = 1\text{ mA}$                  | 4.75           | 5    | 5.25 | V    |
| Input regulation                       | $V_{CC} = 7\text{ V to }40\text{ V}$ |                | 2    | 25   | mV   |
| Output regulation                      | $I_O = 1\text{ mA to }10\text{ mA}$  |                | 1    | 15   | mV   |
| Output voltage change with temperature | $\Delta T_A = \text{MIN to MAX}$     |                | 2    | 10   | mV/V |
| Short-circuit output current§          | REF = 0 V                            |                | 25   |      | mA   |

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values, except for parameter changes with temperature, are at  $T_A = 25^\circ\text{C}$ .

§ Duration of the short circuit should not exceed one second.

### oscillator section, $C_T = 0.01\text{ }\mu\text{F}$ , $R_T = 12\text{ k}\Omega$ (see Figure 1)

| PARAMETER                          | TEST CONDITIONS†                                                | TL494, TL494I |      |     | UNIT   |
|------------------------------------|-----------------------------------------------------------------|---------------|------|-----|--------|
|                                    |                                                                 | MIN           | TYP‡ | MAX |        |
| Frequency                          |                                                                 |               | 10   |     | kHz    |
| Standard deviation of frequency¶   | All values of $V_{CC}$ , $C_T$ , $R_T$ , and $T_A$ constant     |               | 100  |     | Hz/kHz |
| Frequency change with voltage      | $V_{CC} = 7\text{ V to }40\text{ V}$ , $T_A = 25^\circ\text{C}$ |               | 1    |     | Hz/kHz |
| Frequency change with temperature# | $\Delta T_A = \text{MIN to MAX}$                                |               |      | 10  | Hz/kHz |

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values, except for parameter changes with temperature, are at  $T_A = 25^\circ\text{C}$ .

¶ Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

$$\sigma = \sqrt{\frac{\sum_{n=1}^N (x_n - \bar{x})^2}{N - 1}}$$

# Temperature coefficient of timing capacitor and timing resistor are not taken into account.

### error-amplifier section (see Figure 2)

| PARAMETER                        | TEST CONDITIONS                                                                             | TL494, TL494I      |      |     | UNIT          |
|----------------------------------|---------------------------------------------------------------------------------------------|--------------------|------|-----|---------------|
|                                  |                                                                                             | MIN                | TYP‡ | MAX |               |
| Input offset voltage             | $V_O (\text{FEEDBACK}) = 2.5\text{ V}$                                                      |                    | 2    | 10  | mV            |
| Input offset current             | $V_O (\text{FEEDBACK}) = 2.5\text{ V}$                                                      |                    | 25   | 250 | nA            |
| Input bias current               | $V_O (\text{FEEDBACK}) = 2.5\text{ V}$                                                      |                    | 0.2  | 1   | $\mu\text{A}$ |
| Common-mode input voltage range  | $V_{CC} = 7\text{ V to }40\text{ V}$                                                        | -0.3 to $V_{CC}-2$ |      |     | V             |
| Open-loop voltage amplification  | $\Delta V_O = 3\text{ V}$ , $R_L = 2\text{ k}\Omega$ , $V_O = 0.5\text{ V to }3.5\text{ V}$ | 70                 | 95   |     | dB            |
| Unity-gain bandwidth             | $V_O = 0.5\text{ V to }3.5\text{ V}$ , $R_L = 2\text{ k}\Omega$                             |                    | 800  |     | kHz           |
| Common-mode rejection ratio      | $\Delta V_O = 40\text{ V}$ , $T_A = 25^\circ\text{C}$                                       | 65                 | 80   |     | dB            |
| Output sink current (FEEDBACK)   | $V_{ID} = -15\text{ mV to }-5\text{ V}$ , $V (\text{FEEDBACK}) = 0.7\text{ V}$              | 0.3                | 0.7  |     | mA            |
| Output source current (FEEDBACK) | $V_{ID} = 15\text{ mV to }5\text{ V}$ , $V (\text{FEEDBACK}) = 3.5\text{ V}$                | -2                 |      |     | mA            |

‡ All typical values, except for parameter changes with temperature, are at  $T_A = 25^\circ\text{C}$ .



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**electrical characteristics over recommended operating free-air temperature range,  $V_{CC} = 15\text{ V}$ ,  $f = 10\text{ kHz}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)**

**reference section**

| PARAMETER                                 | TEST CONDITIONS <sup>†</sup>         | TL494Y |                  |     | UNIT |
|-------------------------------------------|--------------------------------------|--------|------------------|-----|------|
|                                           |                                      | MIN    | TYP <sup>†</sup> | MAX |      |
| Output voltage (REF)                      | $I_O = 1\text{ mA}$                  |        | 5                |     | V    |
| Input regulation                          | $V_{CC} = 7\text{ V to }40\text{ V}$ |        | 2                |     | mV   |
| Output regulation                         | $I_O = 1\text{ mA to }10\text{ mA}$  |        | 1                |     | mV   |
| Short-circuit output current <sup>‡</sup> | REF = 0 V                            |        | 25               |     | mA   |

<sup>†</sup> All typical values, except for parameter changes with temperature, are at  $T_A = 25^\circ\text{C}$ .

<sup>‡</sup> Duration of the short circuit should not exceed one second.

**oscillator section,  $C_T = 0.01\text{ }\mu\text{F}$ ,  $R_T = 12\text{ k}\Omega$  (see Figure 1)**

| PARAMETER                                    | TEST CONDITIONS <sup>†</sup>                                | TL494Y |                  |     | UNIT   |
|----------------------------------------------|-------------------------------------------------------------|--------|------------------|-----|--------|
|                                              |                                                             | MIN    | TYP <sup>†</sup> | MAX |        |
| Frequency                                    |                                                             |        | 10               |     | kHz    |
| Standard deviation of frequency <sup>§</sup> | All values of $V_{CC}$ , $C_T$ , $R_T$ , and $T_A$ constant |        | 100              |     | Hz/kHz |
| Frequency change with voltage                | $V_{CC} = 7\text{ V to }40\text{ V}$                        |        | 1                |     | Hz/kHz |

<sup>†</sup> All typical values, except for parameter changes with temperature, are at  $T_A = 25^\circ\text{C}$ .

<sup>§</sup> Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

$$\sigma = \sqrt{\frac{\sum_{n=1}^N (x_n - \bar{X})^2}{N - 1}}$$

**error-amplifier section (see Figure 2)**

| PARAMETER                       | TEST CONDITIONS                                                                             | TL494Y |                  |     | UNIT          |
|---------------------------------|---------------------------------------------------------------------------------------------|--------|------------------|-----|---------------|
|                                 |                                                                                             | MIN    | TYP <sup>†</sup> | MAX |               |
| Input offset voltage            | $V_O$ (FEEDBACK) = 2.5 V                                                                    |        | 2                |     | mV            |
| Input offset current            | $V_O$ (FEEDBACK) = 2.5 V                                                                    |        | 25               |     | nA            |
| Input bias current              | $V_O$ (FEEDBACK) = 2.5 V                                                                    |        | 0.2              |     | $\mu\text{A}$ |
| Open-loop voltage amplification | $\Delta V_O = 3\text{ V}$ , $R_L = 2\text{ k}\Omega$ , $V_O = 0.5\text{ V to }3.5\text{ V}$ |        | 95               |     | dB            |
| Unity-gain bandwidth            | $V_O = 0.5\text{ V to }3.5\text{ V}$ , $R_L = 2\text{ k}\Omega$                             |        | 800              |     | kHz           |
| Common-mode rejection ratio     | $\Delta V_O = 40\text{ V}$                                                                  |        | 80               |     | dB            |
| Output sink current (FEEDBACK)  | $V_{ID} = -15\text{ mV to }-5\text{ V}$ , $V$ (FEEDBACK) = 0.7 V                            |        | 0.7              |     | mA            |

<sup>†</sup> All typical values, except for parameter changes with temperature, are at  $T_A = 25^\circ\text{C}$ .

# TL494

## PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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**electrical characteristics over recommended operating free-air temperature range,  $V_{CC} = 15\text{ V}$ ,  $f = 10\text{ kHz}$  (unless otherwise noted)**

### output section

| PARAMETER                            |                  | TEST CONDITIONS                                                 | TL494, TL494Y |      |      | UNIT          |
|--------------------------------------|------------------|-----------------------------------------------------------------|---------------|------|------|---------------|
|                                      |                  |                                                                 | MIN           | TYP† | MAX  |               |
| Collector off-state current          |                  | $V_{CE} = 40\text{ V}$ , $V_{CC} = 40\text{ V}$                 |               | 2    | 100  | $\mu\text{A}$ |
| Emitter off-state current            |                  | $V_{CC} = V_C = 40\text{ V}$ , $V_E = 0$                        |               |      | –100 | $\mu\text{A}$ |
| Collector-emitter saturation voltage | Common emitter   | $V_E = 0$ , $I_C = 200\text{ mA}$                               |               | 1.1  | 1.3  | V             |
|                                      | Emitter follower | $V_{O(C1\text{ or }C2)} = 15\text{ V}$ , $I_E = -200\text{ mA}$ |               | 1.5  | 2.5  |               |
| Output control input current         |                  | $V_I = V_{ref}$                                                 |               |      | 3.5  | mA            |

† All typical values except for temperature coefficient are at  $T_A = 25^\circ\text{C}$ .

### dead-time control section (see Figure 1)

| PARAMETER                                |                    | TEST CONDITIONS                                                                        | TL494, TL494Y |      |     | UNIT          |
|------------------------------------------|--------------------|----------------------------------------------------------------------------------------|---------------|------|-----|---------------|
|                                          |                    |                                                                                        | MIN           | TYP† | MAX |               |
| Input bias current (DEAD-TIME CTRL)      |                    | $V_I = 0\text{ to }5.25\text{ V}$                                                      |               | –2   | –10 | $\mu\text{A}$ |
| Maximum duty cycle, each output          |                    | $V_I$ (DEAD-TIME CTRL) = 0, $C_T = 0.1\text{ }\mu\text{F}$ , $R_T = 12\text{ k}\Omega$ |               | 45%  |     |               |
| Input threshold voltage (DEAD-TIME CTRL) | Zero duty cycle    |                                                                                        |               | 3    | 3.3 | V             |
|                                          | Maximum duty cycle |                                                                                        |               | 0    |     |               |

† All typical values except for temperature coefficient are at  $T_A = 25^\circ\text{C}$ .

### PWM comparator section (see Figure 1)

| PARAMETER                          |  | TEST CONDITIONS        | TL494, TL494Y |      |     | UNIT |
|------------------------------------|--|------------------------|---------------|------|-----|------|
|                                    |  |                        | MIN           | TYP† | MAX |      |
| Input threshold voltage (FEEDBACK) |  | Zero duty cycle        |               | 4    | 4.5 | V    |
| Input sink current (FEEDBACK)      |  | $V$ (FEEDBACK) = 0.7 V | 0.3           | 0.7  |     | mA   |

† All typical values except for temperature coefficient are at  $T_A = 25^\circ\text{C}$ .

### total device

| PARAMETER              | TEST CONDITIONS                              |            | TL494, TL494Y |      |     | UNIT |
|------------------------|----------------------------------------------|------------|---------------|------|-----|------|
|                        |                                              |            | MIN           | TYP† | MAX |      |
| Standby supply current | RT = Vref, All other inputs and outputs open | VCC = 15 V | 6             | 10   | mA  |      |
|                        |                                              | VCC = 40 V | 9             | 15   |     |      |
| Average supply current | VI (DEAD-TIME CTRL) = 2 V, See Figure 1      |            | 7.5           |      | mA  |      |

† All typical values except for temperature coefficient are at  $T_A = 25^\circ\text{C}$ .

### switching characteristics, $T_A = 25^\circ\text{C}$

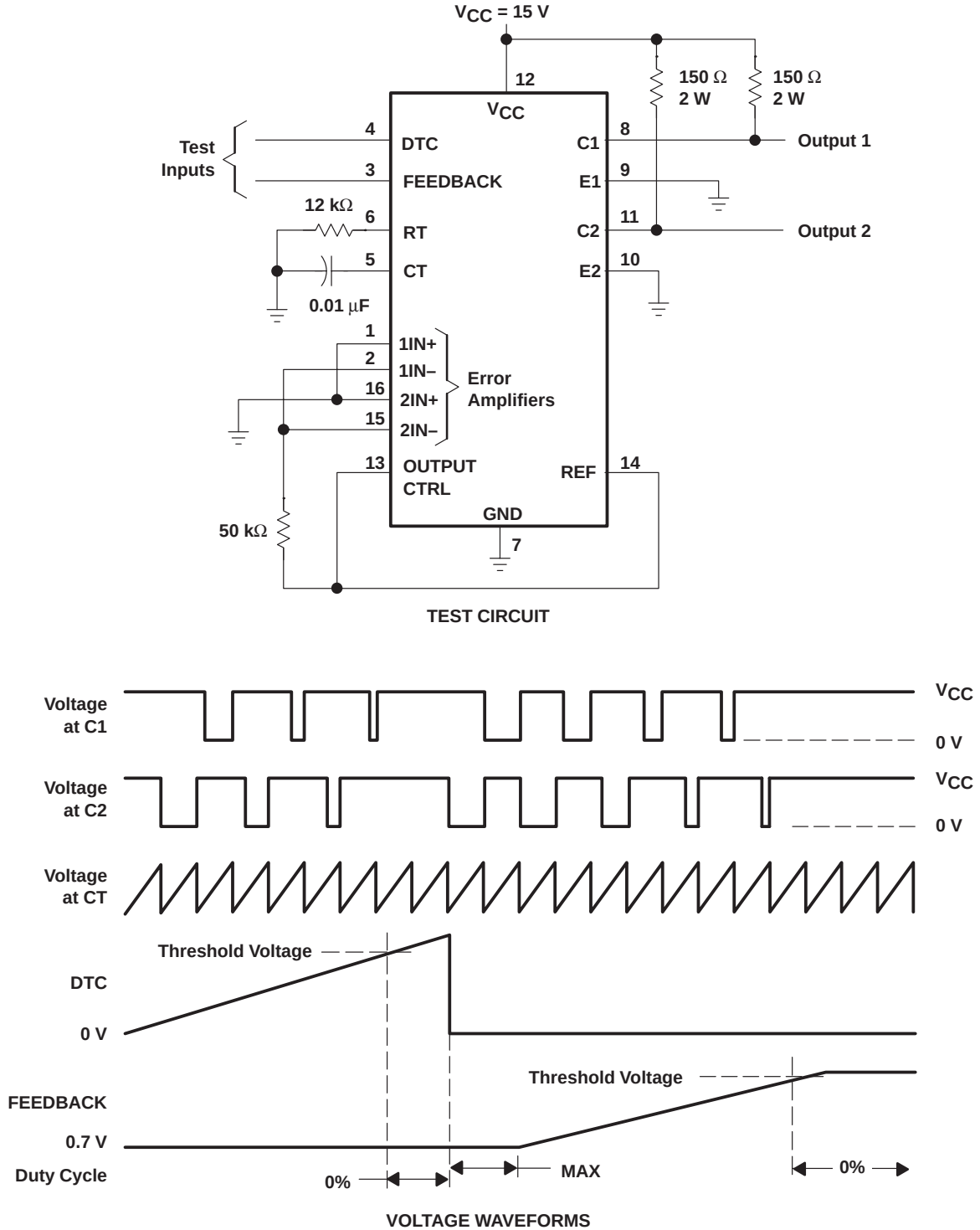
| PARAMETER |                                              | TEST CONDITIONS | TL494, TL494Y |      |     | UNIT |
|-----------|----------------------------------------------|-----------------|---------------|------|-----|------|
|           |                                              |                 | MIN           | TYP† | MAX |      |
| Rise time | Common-emitter configuration, See Figure 3   |                 |               | 100  | 200 | ns   |
| Fall time |                                              |                 |               | 25   | 100 |      |
| Rise time | Emitter-follower configuration, See Figure 4 |                 |               | 100  | 200 | ns   |
| Fall time |                                              |                 |               | 40   | 100 |      |

† All typical values except for temperature coefficient are at  $T_A = 25^\circ\text{C}$ .



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PARAMETER MEASUREMENT INFORMATION



# TL494

## PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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### PARAMETER MEASUREMENT INFORMATION

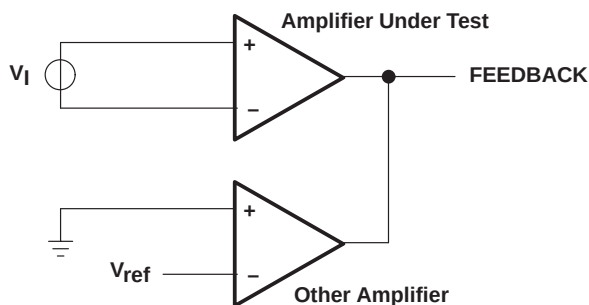
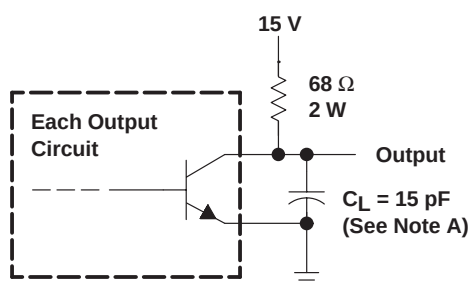
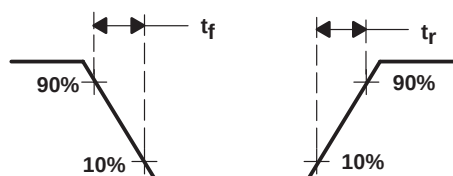


Figure 2. Amplifier Characteristics



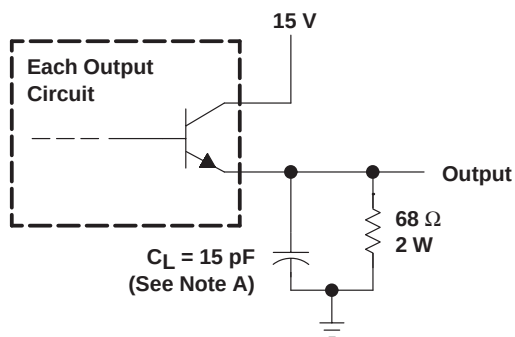
TEST CIRCUIT



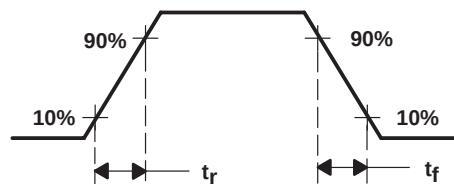
OUTPUT VOLTAGE WAVEFORM

NOTE A:  $C_L$  includes probe and jig capacitance.

Figure 3. Common-Emitter Configuration



TEST CIRCUIT



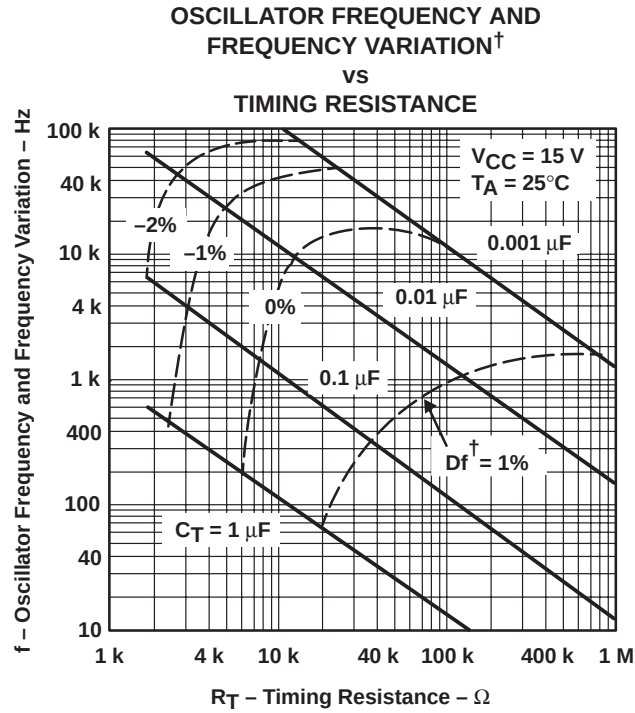
OUTPUT VOLTAGE WAVEFORM

NOTE A:  $C_L$  includes probe and jig capacitance.

Figure 4. Emitter-Follower Configuration



## TYPICAL CHARACTERISTICS



<sup>†</sup> Frequency variation ( $\Delta f$ ) is the change in oscillator frequency that occurs over the full temperature range.

Figure 5

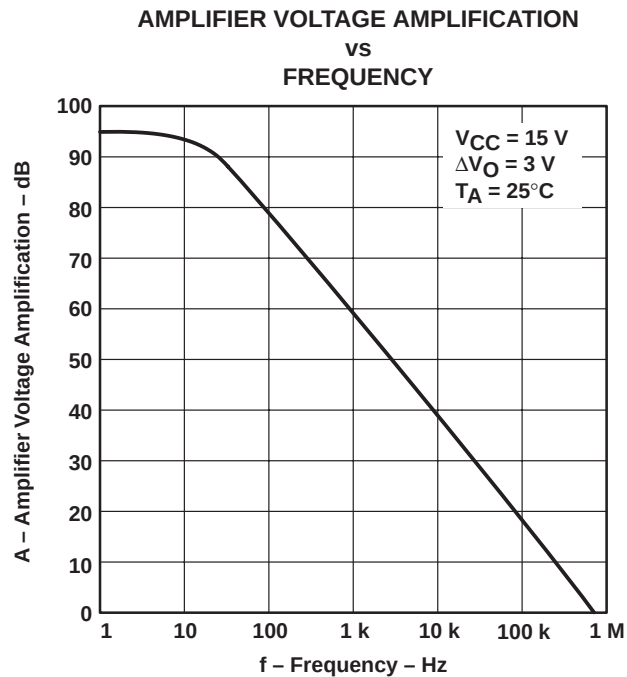


Figure 6

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